Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/786,960	TANAKA ET AL.	:
Examiner	Art Unit	
Tuan V. Thai	2186	

SEARCHED					
Class	Subclass	Date	Examiner		
711	3	12/5/2005	тн		
711	4	12/5/2005	тн		
711	5	12/5/2005	ТН		
711	103	12/5/2005	ТН		
711	154	12/5/2005	тн		
711	200	12/5/2005	тн		
711	206	12/5/2005	ТН		
711	207	12/5/2005	th		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
711	103	12/5/2005	ТН			
711	205	12/5/2005	тн			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST searches: DERWENTS USPGPUB EPO/JPO abst IBMTDB NORTH database NPL search IEEE search	12/5/2005	тн	